imall

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832 Email & Skype: info@chipsmall.com Web: www.chipsmall.com Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China



ACPL-K30T Automotive Photovoltaic MOSFET Driver with R²CouplerTM Isolation



Data Sheet



Description

The ACPL-K30T is specially designed to drive high-voltage MOSFETs. It consists of an AlGaAs infrared Light-Emitting Diode (LED) input stage optically coupled to an output detector circuit. The detector consists of a high-speed photovoltaic diode array and a turn-off circuit. The photovoltaic driver is turned on (contact closes) with a minimum input current of 5 mA through the input LED. The relay driver is turned off (contact opens) with an input voltage of 0.8 V or less.

ACPL-K30T is available in the stretched SO-8 package outline, designed to be compatible with standard surface mount processes.

Avago R²Coupler isolation products provide reinforced insulation and reliability that delivers safe signal isolation critical in automotive and high-temperature industrial applications.

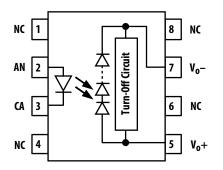


Figure 1. ACPL-K30T Functional Diagram

Features

- Qualified to AEC-Q100 Grade 1 Test Guidelines
- Automotive temperature range: -40 °C to +125 °C
- Photovoltaic Driver for High Voltage MOSFETs for Automotive Application
- Open Circuit Voltage: 7 V Typical at I_F =10 mA
- Short Circuit Current: 5 μ A Typical at I_F =10 mA
- Logic Circuit Compatibility
- Switching Speed: 0.8 ms (T_ON), 0.04 ms (T_OFF) Typical at I_F = 10 mA, $\,C_L$ = 1 nF
- Configurable to wide portfolio of high voltage MOSFETs
- Galvanic Isolation
- High Input-to-Output Insulation Voltage
- Safety and Regulatory Approvals
 - IEC/EN/DIN EN 60747-5-5 Maximum Working Insulation Voltage 1140 V_{PEAK}
 - 5000 V_{RMS} for 1 minute per UL1577
 - CSA Component Acceptance

Applications

- Battery Insulation Resistance Measurement/Leakage Detection
- BMS Flying Capacitor Topology for Sensing Batteries
- Solid State Relay Module

CAUTION: It is advised that normal static precautions be taken in handling and assembly of this component to prevent damage and/or degradation, which may be induced by ESD.

Typical Application Circuit

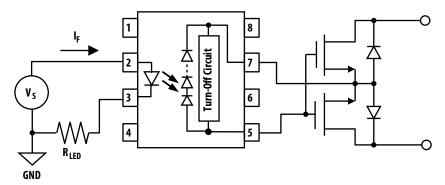
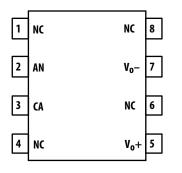


Figure 2. Application Circuit

Package Pinout



Pin Description

Pin Name	Description
AN	Anode
CA	Cathode
V _O +	Positive Output
V _O -	Negative Output
NC	Not Connected
	CA V _O + V _O -

Ordering Information

	Option		Surface	Таре	UL 5000 V _{RMS} /	IEC/EN/DIN EN	
Part number	(RoHS Compliant)	Package	Mount	& Reel	1 Minute rating	60747-5-5	Quantity
ACPL-K30T	-000E	Stretched	Х		Х		80 per tube
	-060E	SO-8	Х		Х	Х	80 per tube
	-500E	-	Х	Х	Х		1000 per ree
	-560E	_	Х	Х	Х	Х	1000 per ree

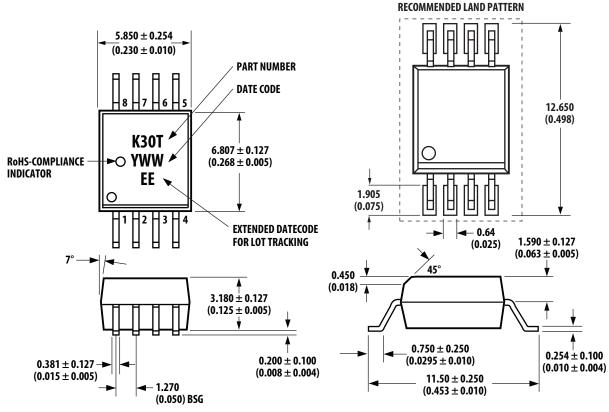
To order, choose a part number from the part number column and combine with the desired option from the option column to form an order entry.

Example 1:

ACPL-K30T-560E: to order product of SSO-8 Surface Mount package in Tape and Reel packaging with IEC/EN/DIN EN 60747-5-5 Safety Approval in RoHS compliant.

Option datasheets are available. Contact your Avago sales representative or authorized distributor for information.

Package Outline Drawings (Stretched SO8)



Dimensions in millimeters and (inches).

Notes: Lead coplanarity = 0.1 mm (0.004 inches). Floating lead protrusion = 0.25 mm (10 mils) max.

Recommended Pb-Free IR Profile

Recommended reflow condition as per JEDEC Standard J-STD-020 (latest revision).

Note: Non-halide flux should be used.

Regulatory Information

The ACPL-K30T is approved by the following organizations:

UL	CSA
UL 1577, component recognition program up to V _{ISO} = 5 kV _{RMS}	Approved under CSA Component Acceptance Notice #5

IEC/EN/DIN EN 60747-5-5

IEC 60747-5-5 EN 60747-5-5 DIN EN 60747-5-5

Insulation and Safety Related Specifications

Parameter	Symbol	ACPL-K30T	Units	Conditions
Minimum External Air Gap (Clearance)	L(101)	8	mm	Measured from input terminals to output terminals, shortest distance through air.
Minimum External Tracking (Creepage)	L(102)	8	mm	Measured from input terminals to output terminals, shortest distance path along body.
Minimum Internal Plastic Gap (Internal Clearance)		0.08	mm	Through insulation distance conductor to conductor, usually the straight line distance thickness between the emitter and detector.
Tracking Resistance (Comparative Tracking Index)	CTI	175	V	DIN IEC 112/VDE 0303 Part 1
Isolation Group (DIN VDE0109)		Illa		Material Group (DIN VDE 0109)

IEC/EN/DIN EN 60747-5-5 Insulation Related Characteristic (Option 060 and 560 only)

Description	Symbol	Option 060 and 560	Units
Installation classification per DIN VDE 0110/1.89, Table 1 for rated mains voltage < 600 V _{RMS}		I - IV	
for rated mains voltage < 1000 V _{RMS}		-	
Climatic Classification		40/125/21	
Pollution Degree (DIN VDE 0110/1.89)		2	
Maximum Working Insulation Voltage	VIORM	1140	V _{PEAK}
Input to Output Test Voltage, Method b $V_{IORM} imes 1.875 = V_{PR}$, 100% Production Test with t _m = 1 sec Partial Discharge < 5 pC	V _{PR}	2137	Vpeak
Input to Output Test Voltage, Method a V _{IORM} × 1.6 = V _{PR} , Type and sample test, t _m = 10 sec, Partial Discharge < 5 pC	V _{PR}	1824	Vpeak
Highest Allowable Overvoltage (Transient Overvoltage, t _{ini} = 60 sec)	VIOTM	8000	VPEAK
Safety Limiting Values (Maximum values allowed in the event of a failure) Case Temperature Input Current Output Power	Ts I _{s,input} P _{s,output}	175 230 600	°C mA mW
Insulation Resistance at T_s , $V_{IO} = 500 V$	Rs	>109	Ω

Absolute Maximum Ratings

Parameter		Symbol	Min.	Max.	Units	Notes
Storage Temper	ature	Ts	-55	150	°C	
Operating Amb	ient Temperature	T _A	-40	125	°C	
Input Current	Average	I _{F(avg)}		30	mA	
	Surge (50% duty cycle)	I _{F(surge)}		60	mA	
	Transient (\leq 1 μ s pulse width, 300 pps)	I _{F(trans)}		1	А	
Reversed Input	Voltage	V _R		6	V	
Input Power Dis	sipation	P _{IN}		60	mW	
Lead Soldering	Temperature			260	°C	
Cycle	Time			10	S	
Solder Reflow Temperature Profile		Recommende J-STD-020 (la	ed reflow conc test revision)	lition as pe	er JEDEC S	standard

Recommended Operating Conditions

Parameter	Symbol	Min.	Max.	Units	Note
Input Current (ON)	I _{F(ON)}	10	20	mA	
			30		Pulse width < 1 s, duty cycle < 50%
Input Voltage (OFF)	V _{F(OFF)}	0	0.8	V	
Operating Temperature	T _A	-40	125	°C	

Electrical Specifications (DC)

Unless otherwise stated, all minimum/maximum specifications are over recommended operating conditions. All typical values are at $T_A = 25$ °C.

Parameter	Symbol	Min.	Тур.	Max.	Units	Test Conditions	Figures	Notes
Open Circuit Voltage	V _{OC}	4.0	7		V	$I_F = 10 \text{ mA}, I_O = 0 \text{ mA}$	3, 4	
		4.5			_	$I_F = 10 \text{mA}, I_O = 0 \text{ mA}, T_A = 105 \text{ °C}$		
		4.5	7.5		-	$I_F = 20 \text{ mA}, I_O = 0 \text{ mA}$	3, 4	
Temperature Coefficient of Open Circuit Voltage	$\Delta V_{OC} / \Delta T_A$		-21		mV/°C	$I_F = 10 \text{ mA}, I_O = 0 \text{ mA}$	4	
Short Circuit Current	lsc	2.0	5.0		μΑ	$I_F = 10 \text{ mA}, V_O = 0 \text{ V}$	5,6	
	·	4.0	10.0		_	$I_F = 20 \text{ mA}, V_O = 0 \text{ V}$	5,6	
Input Forward Voltage	V _F	1.25	1.55	1.85	V	I _F =10 mA		
Temperature Coefficient of Forward Voltage	$\Delta V_F / \Delta T_A$		-1.5		mV/°C	I _F =10 mA		
Input Reverse Breakdown Voltage	BV _R	6			V	I _R =10 μA		

Switching Specifications (AC)

Unless otherwise stated, all minimum/maximum specifications are over recommended operating conditions. All typical values are at $T_A = 25$ °C.

Parameter	Symbol	Min.	Тур.	Max.	Units	Test Conditions	Figures	Notes
Turn-On Time	T _{ON}		0.8	2.0	ms	I _F =10 mA, C _L = 1 nF	7,10,11	
			0.4	1.0		I _F =20 mA, C _L = 1 nF	7,10,11	
Turn-Off Time	T _{OFF}		0.04	0.12	ms	$I_F = 10 \text{ mA}/20 \text{ mA}, C_L = 1 \text{ nF}$	8, 9,11	

Package Characteristics

Unless otherwise stated, all minimum/maximum specifications are over recommended operating conditions. All typical values are at $T_A = 25$ °C.

Parameter	Symbol	Min.	Тур.	Max.	Units	Test Conditions	Figures	Notes
Input-Output Momentary Withstand Voltage*	V _{ISO}	5000			V _{RMS}	RH \leq 50%, t = 1 minute, T _A = 25 °C		1, 2
Input-Output Resistance	R _{I-O}	10 ⁹	10 ¹⁴		Ω	$V_{I-O} = 500 V_{DC}$		1
Input-Output Capacitance	CI-O		0.6		pF	$f = 1 MHz$, $V_{I-O} = 0 V_{DC}$		1

* The Input-Output Momentary Withstand Voltage is a dielectric voltage rating that should not be interpreted as an input-output continuous voltage rating.

Notes:

1. Device considered a two-terminal device: pins 1, 2, 3 and 4 shorted together, and pins 5, 6, 7 and 8 shorted together.

2. In accordance with UL 1577, each optocoupler is proof-tested by applying an insulation test voltage > 6000 V_{RMS} for 1 second.

Typical Characteristic Plots and Test Conditions

Unless otherwise stated, all typical values are at $T_A = 25$ °C.

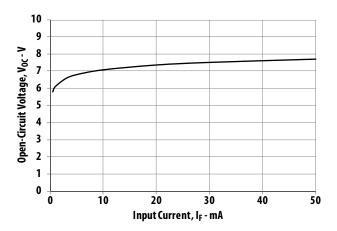


Figure 3. Open Circuit Voltage vs. Input LED Current

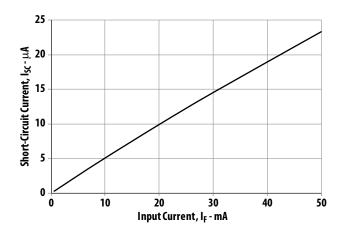


Figure 5. Short Circuit Current vs. Input LED Current

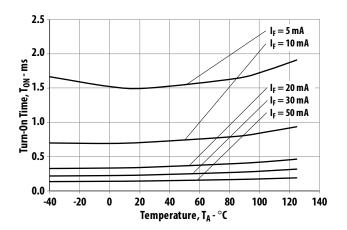


Figure 7. Turn-On Time vs. Temperature

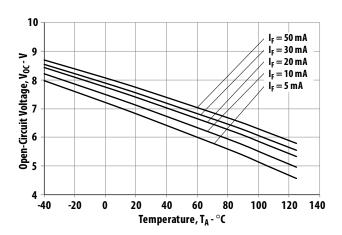


Figure 4. Open Circuit Voltage vs. Temperature

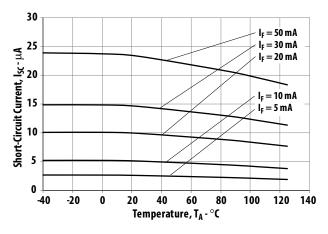


Figure 6. Short Circuit Current vs. Temperature

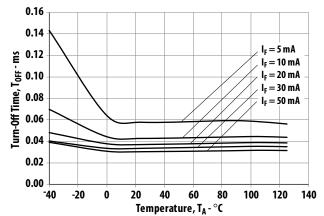


Figure 8. Turn-Off Time vs. Temperature

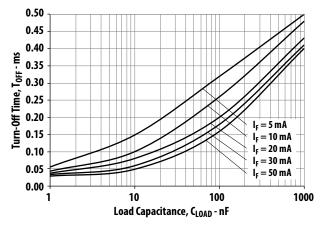


Figure 9. Turn-Off Time vs. Load Capacitance

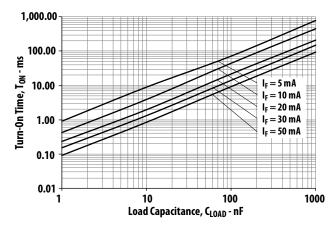


Figure 10. Turn-On Time vs. Load Capacitance

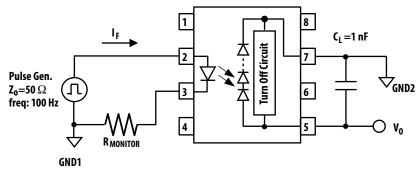
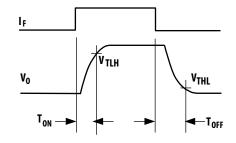


Figure 11. Switching Time Test Circuit and Waveform



Note: These are the test conditions: $T_A = -40 \ ^\circ C$, $V_{TLH} = 3.6 \ V$, $V_{THL} = 1.2 \ V$ $T_A = 25 \ ^\circ C$, $V_{TLH} = 3.6 \ V$, $V_{THL} = 1.0 \ V$ $T_A = 125 \ ^\circ C$, $V_{TLH} = 3.6 \ V$, $V_{THL} = 0.8 \ V$

Application Information

The ACPL-K30T automotive photovoltaic (PV) driver is a device that is paired with MOSFETs to form basic building block of several types of application. It consists of an Al-GaAs LED input that is optically coupled to a photovoltaic diode array. This becomes a voltage source with galvanic isolation. The advantage of photovoltaic driver is its simple design which does not require bias supply.

Basic Construction

As shown in Figure 12, the input side of the PV Driver is LED driven. A current limiting resistor is required to limit the current through the LED. Recommended input forward current is 10 mA to 20 mA. The LED is optically coupled through a photodiode stack (D1 to D12) consisting of 12 photodiodes connected in series. When current is driven into the Light-Emitting Diode (LED) on the input side, the light from the LED generates photo current on the string of photodiodes to charge the gate of the MOSFETs, generating a photo-voltage proportional to the number of photodiodes, to switch and keep the power device on.

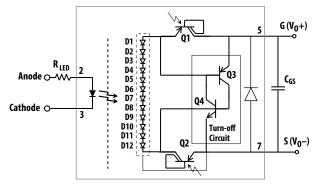


Figure 12. Basic Construction of Photovoltaic Driver

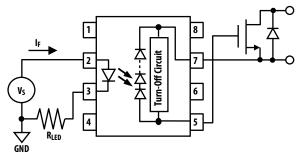


Figure 13. Photovoltaic Driver + Single External MOSFET

PV Driver and MOSFET Configurations

The photovoltaic driver is a device that is combined with high voltage MOSFETs to form a solid-state relay. The photovoltaic driver can be configured with a single MOSFET or two MOSFETS (back to back) for bidirectional application. Pin 5 is connected to the Gate and Pin 7 is connected to the Source. Figure 13 and 14 are sample application circuits for the two configurations.

Turn-Off Circuit

The photovoltaic driver has a built in turn-off circuit, which decreases the turn-off time. This circuit instantaneously discharges the gate capacitance of MOSFETs once the photovoltaic driver is turned off. The turn-off circuit is activated when the photovoltaic voltage is collapsing.

The sequence of operation of the turn-off ciruit:

When LED is ON:

- 1. Q1 and Q2 are saturated.
- 2. SCR (Q3 and Q4) is disabled.
- 3. Photodiode array is connected to Gate and Source.

When LED is OFF:

- 1. Q1 and Q2 cease to conduct.
- 2. Photodiode array is disconnected from Gate and Source.
- 3. SCR (Q3 and Q4) is triggered and Gate capacitance (C_{GS}) is discharged rapidly.

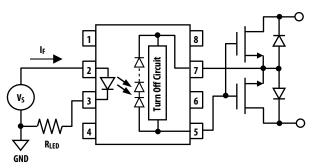


Figure 14. Photovoltaic Driver + Two Back-to-Back MOSFETs

Voc and MOSFET VGS(TH)

ACPL-K30T has typical V_{OC} of 7 V and minimum V_{OC} of 4 V at 125 °C. This is sufficient to drive most logic gate level MOSFETs, with threshold voltages V_{GS(TH)} of 4 V or less. The V_{OC} has a typical temperature coefficient of -21 mV/°C. To serve as a guide in the design at different temperatures, Figure 15 shows the ACPL-K30T's minimum V_{OC} vs. the MOSFET's maximum V_{GS(TH)}.

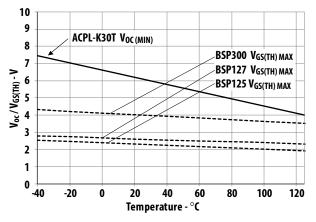


Figure 15. V_{OC} minimum vs. MOSFET V_{GS(TH)} maximum

Two PV Drivers in Series

For high voltage MOSFETs that require higher V_{GS(TH)}, two ACPL-K30T devices can be connected in series. Figure 16 shows the connection for this configuration. Two PV drivers in series will give $2 \times$ higher V_{OC} (Typical = 14 V) compared with a single PV driver.

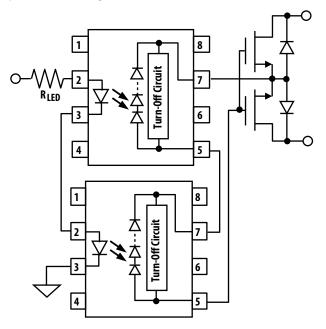


Figure 16. Two PV Drivers in Series

Thermal Resistance Model for ACPL-K30T

The diagram of ACPL-K30T for measurement is shown in Figure 17. Here, one die is heated first and the temperatures of all the dice are recorded after thermal equilibrium is reached. Then, the second die is heated and all the dice temperatures are recorded. With the known ambient temperature, the die junction temperature and power dissipation, the thermal resistance can be calculated. The thermal resistance calculation can be cast in matrix form. This yields a 2 by 2 matrix for our case of two heat sources.

1			8
2	Die 1:	Die 2:	7
3	LED	Detector	6
4			5

Figure 17. Diagram of ACPL-K30T for measurement

R ₁₁	R ₁₂		P ₁		ΔT_1
R ₂₁	R ₂₂	•	P ₁ P ₂	=	ΔT_2

 R_{11} : Thermal Resistance of Die1 due to heating of Die1 $% R_{11}$

R₁₂: Thermal Resistance of Die1 due to heating of Die2.

 R_{21} : Thermal Resistance of Die2 due to heating of Die1.

R₂₂: Thermal Resistance of Die2 due to heating of Die2.

P₁: Power dissipation of Die1 (W).

P₂: Power dissipation of Die2 (W).

T₁: Junction temperature of Die1 due to heat from all dice (°C).

T₂: Junction temperature of Die2 due to heat from all dice.

T_A: Ambient temperature.

 ΔT_1 : Temperature difference between Die1 junction and ambient (°C).

 ΔT_2 : Temperature deference between Die2 junction and ambient (°C).

 $T_1 = R_{11} \times P_1 + R_{12} \times P_2 + T_A$

 $T_2 = R_{21} \times P_1 + R_{22} \times P_2 + T_A$

Measurement data on a low K (connectivity) board:

 $R_{11} = 258 \ ^{\circ}C/W$

R₁₂= 121 °C/W

R21 = 119 °C/W

R₂₂ = 201 °C/W

Measurement data on a high K (connectivity) board:

 $R_{11} = 194 \ ^{\circ}C/W$

R₁₂= 59 °C/W

 $R_{21} = 53 \ ^{\circ}C/W$

 $R_{22} = 136 \ ^{\circ}C/W$

For product information and a complete list of distributors, please go to our web site: www.avagotech.com

Avago, Avago Technologies, and the A logo are trademarks of Avago Technologies in the United States and other countries. Data subject to change. Copyright © 2005-2014 Avago Technologies. All rights reserved. AV02-4500EN - October 9, 2014

